


<b>Search Notes</b>  	<b>Application/Control No.</b>  10764423	<b>Applicant(s)/Patent Under Reexamination</b>  CHANG ET AL.
	<b>Examiner</b>  Holton, Steven E	<b>Art Unit</b>  2629

SEARCHED			
Class	Subclass	Date	Examiner
345	169,173,175, 7-9, 156	3/18/2007	SEH

SEARCH NOTES		
Search Notes	Date	Examiner
East Notes	3/18/2007	SEH
East Notes	1/20/09	SEH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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